

Search Notes**Application/Control No.**

10/553,958

Examiner

Mathieu D. Vargot

**Applicant(s)/Patent under
Reexamination**

SAIKI ET AL.

Art Unit

1791

SEARCHED

Class	Subclass	Date	Examiner
264	1.1, 1.34, 2.6, 2.7, 288.4	3/22/2008	MDV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR